Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under	
	10/500,376	Reexamination INAI, ATSUMI	
Notice of Neterences Offen	Examiner	Art Unit	
	Jean W. Désir	2622	Page 1 of 2

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,347,318 A	09-1994	Kobayashi et al.	348/556
*	В	US-5,448,307 A	09-1995	Gelissen et al.	348/584
*	С	US-5,796,442 A	08-1998	Gove et al.	348/556
*	D	US-5,973,750 A	10-1999	Ogawa et al.	348/570
*	Е	US-5,966,186 A	10-1999	Shigihara et al.	348/570
*	F	US-5,991,832 A	11-1999	Sato et al.	710/33
*	G	US-6,005,629 A	12-1999	Douche et al.	375/240.26
*	Н	US-6,310,654 B1	10-2001	Oku et al.	348/554
*		US-6,452,638 B1	09-2002	Oku et al.	348/441
*	J	US-6,700,624 B2	03-2004	Yun, Hwa Young	348/555
*	К	US-6,741,293 B1	05-2004	Obuchi, Masashi	348/554
*	L	US-7,106,382 B2	09-2006	Shiotsu, Shinichi	348/555
*	М	US-7,116,377 B2	10-2006	Zeidler et al.	348/569

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/500,376 Applicant(s)/Patent Under Reexamination INAI, ATSUMI Examiner Jean W. Désir Art Unit Page 2 of 2

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,461,428 A	10-1995	Yoo, Jaechern	348/558
*	В	US-6,259,487 B1	07-2001	Bril, Vlad	348/553
*	С	US-6,346,972 B1	02-2002	Kim, Young-Chan	348/569
*	D	US-6,351,292 B1	02-2002	Knox et al.	348/569
*	Е	US-6,380,984 B1	04-2002	Inoue et al.	348/569
*	F	US-6,369,858 B1	04-2002	Lee, Jae-Hun	348/569
*	G	US-6,388,715 B1	05-2002	Eggen et al.	348/569
*	Ή	US-6,421,094 B1	07-2002	Han, Dongil	348/569
*	_	US-6,593,937 B2	07-2003	Ludtke et al.	345/629
*	7	US-6,710,817 B2	03-2004	Oku et al.	348/569
*	К	US-6,714,254 B2	03-2004	Enomoto, Mitsunobu	348/564
*	L	US-7,061,542 B1	06-2006	Ikeguchi, Yasuyuki	348/558
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.